

Notice of References Cited	Application/Control No. 10/799,153		Applicant(s)/Patent Under Reexamination ISHIZAKA ET AL.	
	Examiner John P. Sheehan		Art Unit 1742	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0187970 A1	09-2004	Ishizaka et al.	148/302
*	B	US-2004/0187969 A1	09-2004	Ishizaka et al.	148/302
*	C	US-2004/0118484 A1	06-2004	Nishizawa et al.	148/302
*	D	US-6,468,365 B1	10-2002	Uchida et al.	148/302
*	E	US-2002/0112785 A1	08-2002	Sekine et al.	148/302
*	F	US-2002/0007875 A1	01-2002	Yamamoto et al.	148/302
*	G	US-2002/0003006 A1	01-2002	Nishimoto et al.	148/102
*	H	US-6,811,620 B2	11-2004	Ishizaka et al.	148/302
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.